Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/796,205	YAMADA ET AL.	
Examiner	Art Unit	

Jean W. Désir

2622

SEARCHED				
Class	Subclass	Date	Examiner	
348	552 553	1/25/	7	
	836			
	539	7		
	789			
	207.2			
358	1.1			
	1.14			
347	170			
	222,	245		
	263,	177		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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